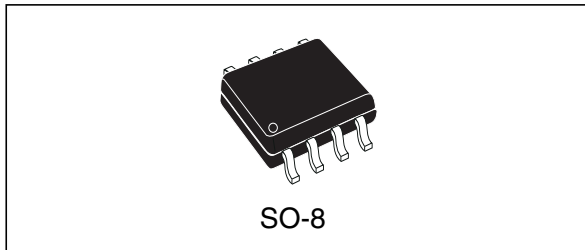


## OMNIFET III fully protected low-side driver for automotive applications

Datasheet - production data



### Description

The VNLD5160-E is a monolithic device made using STMicroelectronics® VIPower® technology, intended for driving resistive or inductive loads with one side connected to the battery. Built-in thermal shutdown protects the chip from overtemperature and short-circuit. Output current limitation protects the device in an overload condition. In case of long duration overload, the device limits the dissipated power to a safe level up to thermal shutdown intervention. Thermal shutdown, with automatic restart, allows the device to recover normal operation as soon as a fault condition disappears. Fast demagnetization of inductive loads is achieved at turn-off.

### Features

Type	V <sub>clamp</sub>	R <sub>DS(on)</sub>	I <sub>D</sub>
VNLD5160-E	41 V	160 mΩ	3.5 A

- AEC-Q100 qualified
- Drain current: 3.5 A
- ESD protection
- Overvoltage clamp
- Thermal shutdown
- Current and power limitation
- Very low standby current
- Very low electromagnetic susceptibility
- Compliant with European directive 2002/95/EC
- Specially intended for R10W or 2xR5W automotive signal lamps



Table 1. Devices summary

Package	Order codes	
	Tube	Tape and reel
SO-8	VNLD5160-E	VNLD5160TR-E

# Contents

- 1      Block diagrams and pins configurations ..... 5**
  
- 2      Electrical specifications ..... 7**
  - 2.1    Absolute maximum ratings ..... 7
  - 2.2    Thermal data ..... 7
  - 2.3    Electrical characteristics ..... 8
  
- 3      Application information ..... 11**
  - 3.1    MCU I/O protection ..... 11
  
- 4      Package and PC board thermal data ..... 13**
  - 4.1    SO-8 thermal data ..... 13
  
- 5      Package and packing information ..... 16**
  - 5.1    SO-8 package information ..... 16
  - 5.2    SO-8 packing information ..... 18
  
- 6      Revision history ..... 19**



## List of tables

Table 1.	Devices summary . . . . .	1
Table 2.	Pin function . . . . .	5
Table 3.	Suggested connections for unused and n.c. pins . . . . .	6
Table 4.	Absolute maximum ratings . . . . .	7
Table 5.	Thermal data . . . . .	7
Table 6.	PowerMOS section . . . . .	8
Table 7.	Source drain diode . . . . .	8
Table 8.	Input section. . . . .	8
Table 9.	Status pin . . . . .	8
Table 10.	Switching characteristics. . . . .	9
Table 11.	Protection and diagnostics . . . . .	9
Table 12.	Truth table. . . . .	10
Table 13.	Thermal parameters . . . . .	15
Table 14.	SO-8 mechanical data . . . . .	17
Table 15.	Document revision history. . . . .	19

## List of figures

Figure 1.	Block diagram . . . . .	5
Figure 2.	Current and voltage conventions . . . . .	6
Figure 3.	Configuration diagrams (top view) . . . . .	6
Figure 4.	Switching characteristics. . . . .	10
Figure 5.	Application schematic. . . . .	11
Figure 6.	Maximum demagnetization energy ( $V_{CC} = 13.5\text{ V}$ ) . . . . .	12
Figure 7.	SO-8 PC board . . . . .	13
Figure 8.	Rthj-amb vs PCB copper area in open box free air condition . . . . .	13
Figure 9.	SO-8 thermal impedance junction ambient single pulse. . . . .	14
Figure 10.	Thermal fitting model of a LSD in SO-8 . . . . .	14
Figure 11.	SO-8 package outline . . . . .	16
Figure 12.	SO-8 tube shipment (no suffix). . . . .	18
Figure 13.	SO-8 tape and reel shipment (suffix "TR") . . . . .	18

# 1 Block diagrams and pins configurations

Figure 1. Block diagram

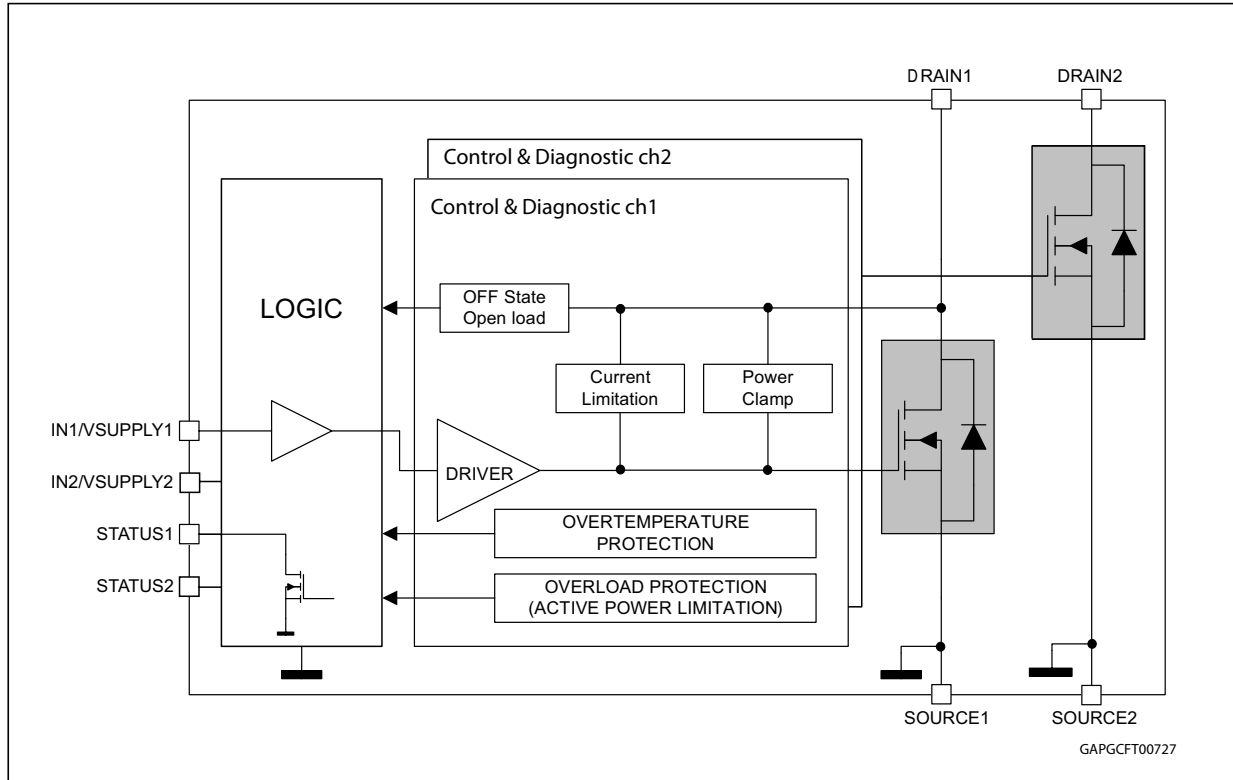


Table 2. Pin function

Name	Function
IN <sub>1,2</sub> /VSUPPLY <sub>1,2</sub>	Voltage controlled input pin with hysteresis, CMOS compatible. They control output switch state.
DRAIN <sub>1,2</sub>	PowerMOS drain.
SOURCE <sub>1,2</sub>	PowerMOS source and ground reference for the control section.
STATUS <sub>1,2</sub>	Open drain digital diagnostic pin.

Figure 2. Current and voltage conventions

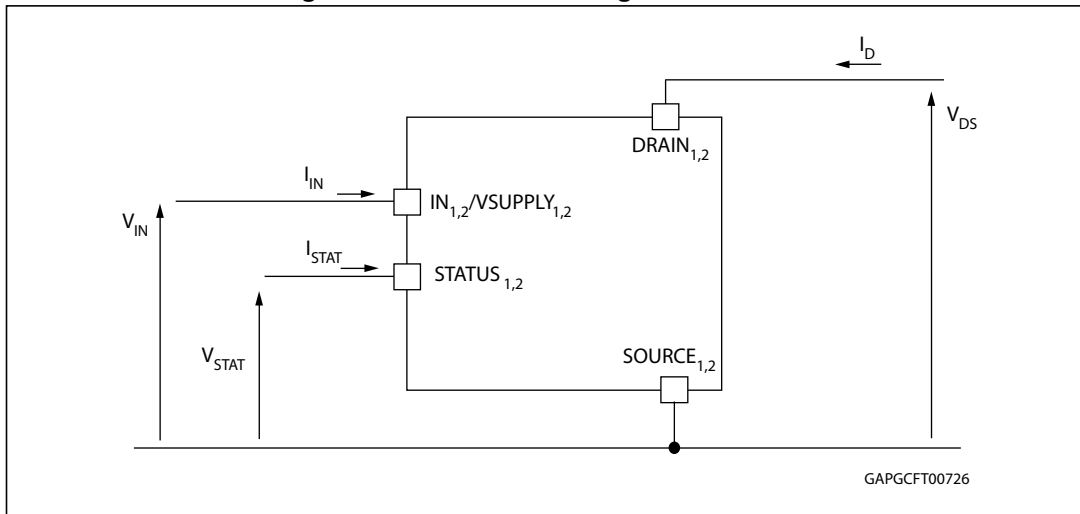


Figure 3. Configuration diagrams (top view)

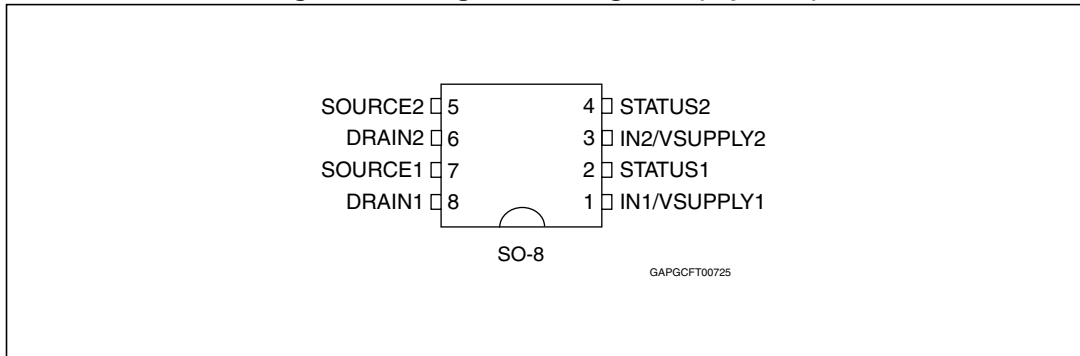


Table 3. Suggested connections for unused and n.c. pins

Connection / pin	STATUS <sub>1,2</sub>	N.C.	INPUT <sub>1,2</sub>
Floating	X <sup>(1)</sup>	X	X
To ground	Not allowed	X	Through 10 kΩ resistor

1. X: do not care.

## 2 Electrical specifications

### 2.1 Absolute maximum ratings

Stressing the device above the rating listed in the [Table 4](#) may cause permanent damage to the device. These are stress ratings only and operation of the device at these or any other conditions above those indicated in the operating sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

**Table 4. Absolute maximum ratings**

Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-source voltage ( $V_{IN} = 0$ V)	Internally clamped	V
$I_D$	DC drain current	Internally limited	A
$-I_D$	Reverse DC drain current	4	A
$I_S$	DC supply current	-1 to 10	mA
$I_{IN}$	DC input current	-1 to 10	mA
$I_{STAT}$	DC status current	-1 to 10	mA
$V_{ESD1}$	Electrostatic discharge ( $R = 1.5$ k $\Omega$ ; $C = 100$ pF) – DRAIN – SUPPLY, INPUT, STATUS	5000 4000	V
$V_{ESD2}$	Electrostatic discharge on output pin only ( $R = 330$ $\Omega$ , $C = 150$ pF)	2000	V
$T_j$	Junction operating temperature	-40 to 150	$^{\circ}$ C
$T_{stg}$	Storage temperature	-55 to 150	$^{\circ}$ C
$E_{AS}$	Single pulse avalanche energy ( $L = 8.5$ mH, $T_J = 150$ $^{\circ}$ C, $R_L = 0$ , $I_{OUT} = I_{limL}$ )	37	mJ

### 2.2 Thermal data

**Table 5. Thermal data**

Symbol	Parameter	Maximum value	Unit
$R_{thj-amb}$	Thermal resistance junction-ambient	111.5	$^{\circ}$ C/W

## 2.3 Electrical characteristics

Values specified in this section are for  $V_{\text{supply}} = V_{\text{IN}} = 4.5 \text{ V to } 5.5 \text{ V}$ ,  $-40 \text{ }^\circ\text{C} < T_j < 150 \text{ }^\circ\text{C}$ , unless otherwise stated.

**Table 6. PowerMOS section**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$R_{\text{ON}}$	ON-state resistance	$I_{\text{D}} = 1 \text{ A}; T_j = 25 \text{ }^\circ\text{C}, V_{\text{supply}} = V_{\text{IN}} = 5 \text{ V}$		160		m $\Omega$
		$I_{\text{D}} = 1 \text{ A}; T_j = 150 \text{ }^\circ\text{C}, V_{\text{supply}} = V_{\text{IN}} = 5 \text{ V}$			320	
$V_{\text{CLAMP}}$	Drain-source clamp voltage	$V_{\text{IN}} = 0 \text{ V}; I_{\text{D}} = 1 \text{ A}$	41	46	52	V
$V_{\text{CLTH}}$	Drain-source clamp threshold voltage	$V_{\text{IN}} = 0 \text{ V}; I_{\text{D}} = 2 \text{ mA}$	36			V
$I_{\text{DSS}}$	OFF-state output current	$V_{\text{IN}} = 0 \text{ V}; V_{\text{DS}} = 13 \text{ V}; T_j = 25 \text{ }^\circ\text{C}$	0		3	$\mu\text{A}$
		$V_{\text{IN}} = 0 \text{ V}; V_{\text{DS}} = 13 \text{ V}; T_j = 125 \text{ }^\circ\text{C}$	0		5	

**Table 7. Source drain diode**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{\text{SD}}$	Forward on voltage	$I_{\text{D}} = 1 \text{ A}; V_{\text{IN}} = 0 \text{ V}$	—	0.8	—	V

**Table 8. Input section**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_{\text{ISS}}$	Supply current from input pin	ON-state: $V_{\text{supply}} = V_{\text{IN}} = 5 \text{ V}; V_{\text{DS}} = 0 \text{ V}$		30	65	$\mu\text{A}$
$V_{\text{ICL}}$	Input clamp voltage	$I_{\text{S}} = 1 \text{ mA}$	5.5		7	V
		$I_{\text{S}} = -1 \text{ mA}$		-0.7		
$V_{\text{INTH}}$	Input threshold voltage	$V_{\text{DS}} = V_{\text{IN}}; I_{\text{D}} = 1 \text{ mA}$	1		3.5	V

**Table 9. Status pin**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{\text{STAT}}$	Status low output voltage	$I_{\text{STAT}} = 1 \text{ mA}$			0.5	V
$I_{\text{LSTAT}}$	Status leakage current	Normal operation; $V_{\text{STAT}} = 5 \text{ V}$			10	$\mu\text{A}$
$C_{\text{STAT}}$	Status pin input capacitance	Normal operation; $V_{\text{STAT}} = 5 \text{ V}$			100	pF
$V_{\text{STCL}}$	Status clamp voltage	$I_{\text{STAT}} = 1 \text{ mA}$	5.5		7	V
		$I_{\text{STAT}} = -1 \text{ mA}$		-0.7		



Table 10. Switching characteristics

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(ON)}$	Turn-on delay time	$R_L = 13 \Omega; V_{CC} = 13 V^{(1)}$	—	8.9	—	$\mu s$
$t_{d(OFF)}$	Turn-off delay time	$R_L = 13 \Omega; V_{CC} = 13 V^{(1)}$	—	13.2	—	$\mu s$
$t_r$	Rise time	$R_L = 13 \Omega; V_{CC} = 13 V^{(1)}$	—	14.1	—	$\mu s$
$t_f$	Fall time	$R_L = 13 \Omega; V_{CC} = 13 V^{(1)}$	—	11.5	—	$\mu s$
$W_{ON}$	Switching energy losses at turn-on	$R_L = 13 \Omega; V_{CC} = 13 V$	—	34.3	—	mJ
$W_{OFF}$	Switching energy losses at turn-off	$R_L = 13 \Omega; V_{CC} = 13 V$	—	34.3	—	mJ

1. See *Figure 4: Switching characteristics*.

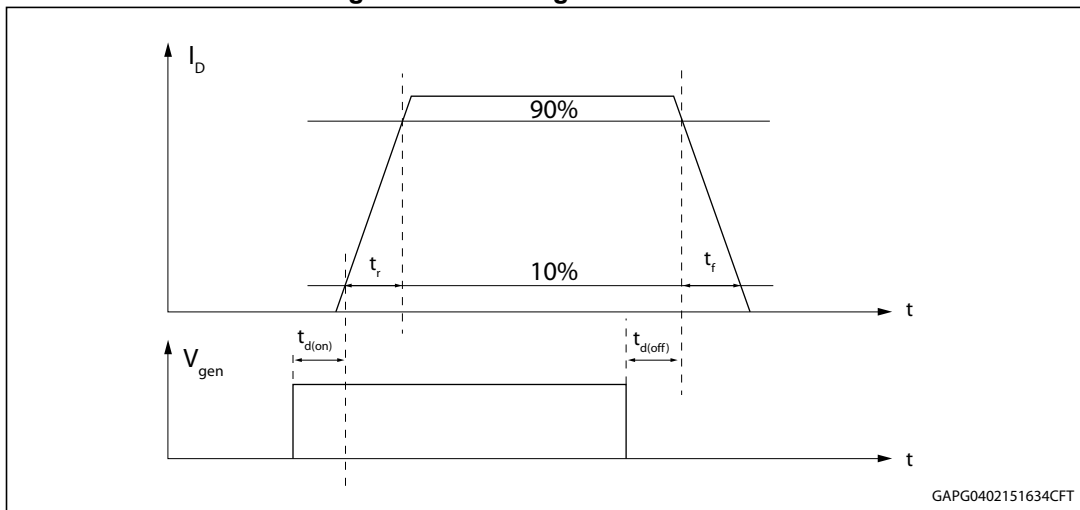
Table 11. Protection and diagnostics

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_{limH}$	DC short-circuit current	$V_{DS} = 13 V;$ $V_{supply} = V_{IN} = 5 V$	3.5	5	7.5	A
$I_{limL}$	Short-circuit current during thermal cycling	$V_{DS} = 13 V; T_R < T_j < T_{TSD};$ $V_{supply} = V_{IN} = 5 V$		2.5		A
$t_{dimL}$	Step response current limit	$V_{DS} = 13 V; V_{input} = 5 V$		20		$\mu s$
$T_{TSD}$	Shutdown temperature		150	175	200	$^{\circ}C$
$T_R$	Reset temperature		$T_{RS} + 1$	$T_{RS} + 5$		$^{\circ}C$
$T_{RS}$	Thermal reset of STATUS		135			$^{\circ}C$
$T_{HYST}$	Thermal hysteresis ( $T_{TSD} - T_R$ )			7		$^{\circ}C$

Table 12. Truth table

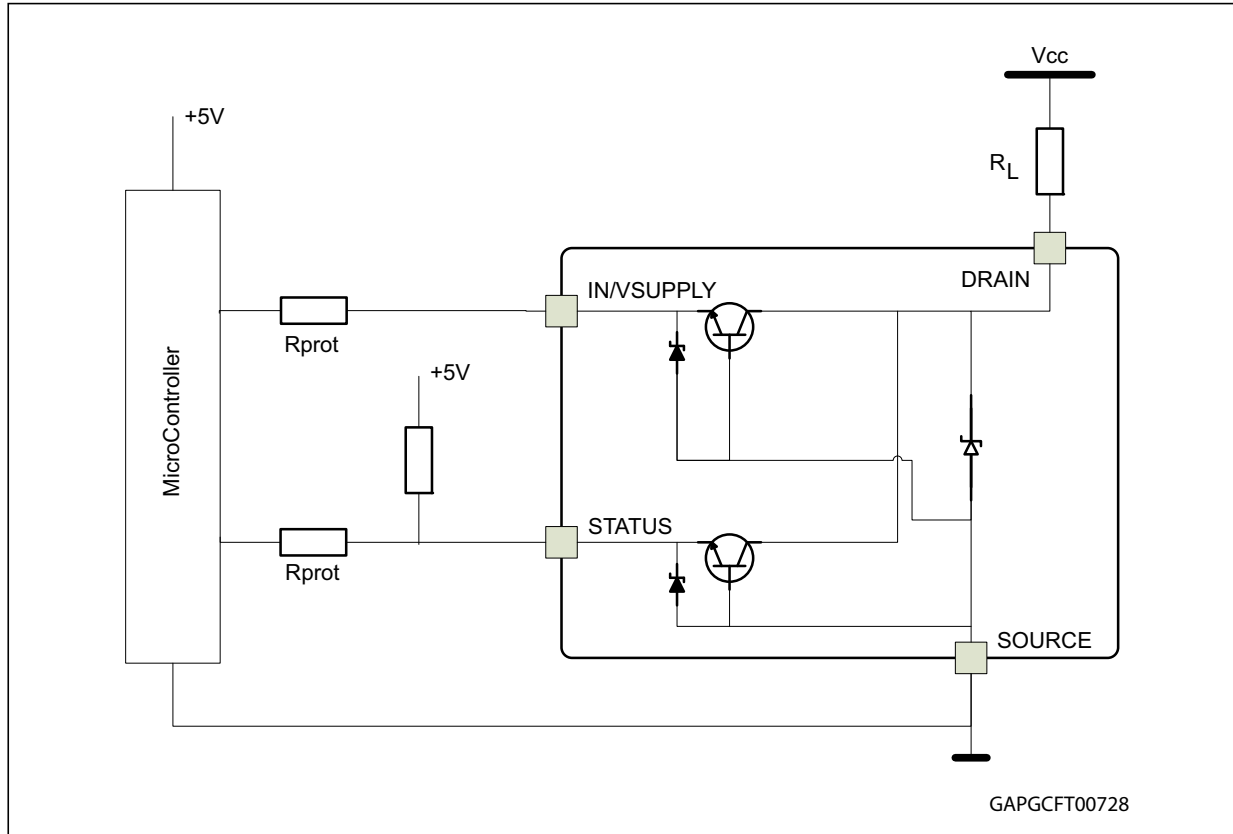
Conditions	INPUT	DRAIN	STATUS
Normal operation	L	H	H
	H	L	H
Current limitation	L	H	H
	H	X	H
Overtemperature	L	H	H
	H	H	L
Undervoltage	L	H	X
	H	H	X

Figure 4. Switching characteristics



### 3 Application information

Figure 5. Application schematic



#### 3.1 MCU I/O protection

ST suggests to insert a resistor ( $R_{prot}$ ) in line to prevent the microcontroller I/O pins from latching up<sup>(a)</sup>. The value of these resistors is a compromise between the leakage current of microcontroller and the current required by the LSD I/Os (input levels compatibility) with the latch-up limit of microcontroller I/Os:

Equation 1

$$\frac{0.7}{I_{latchup}} \leq R_{prot} \leq \frac{(V_{OH\mu C} - V_{IH})}{I_{IH\ max}}$$

a. In case of negative transient on the drain pin.

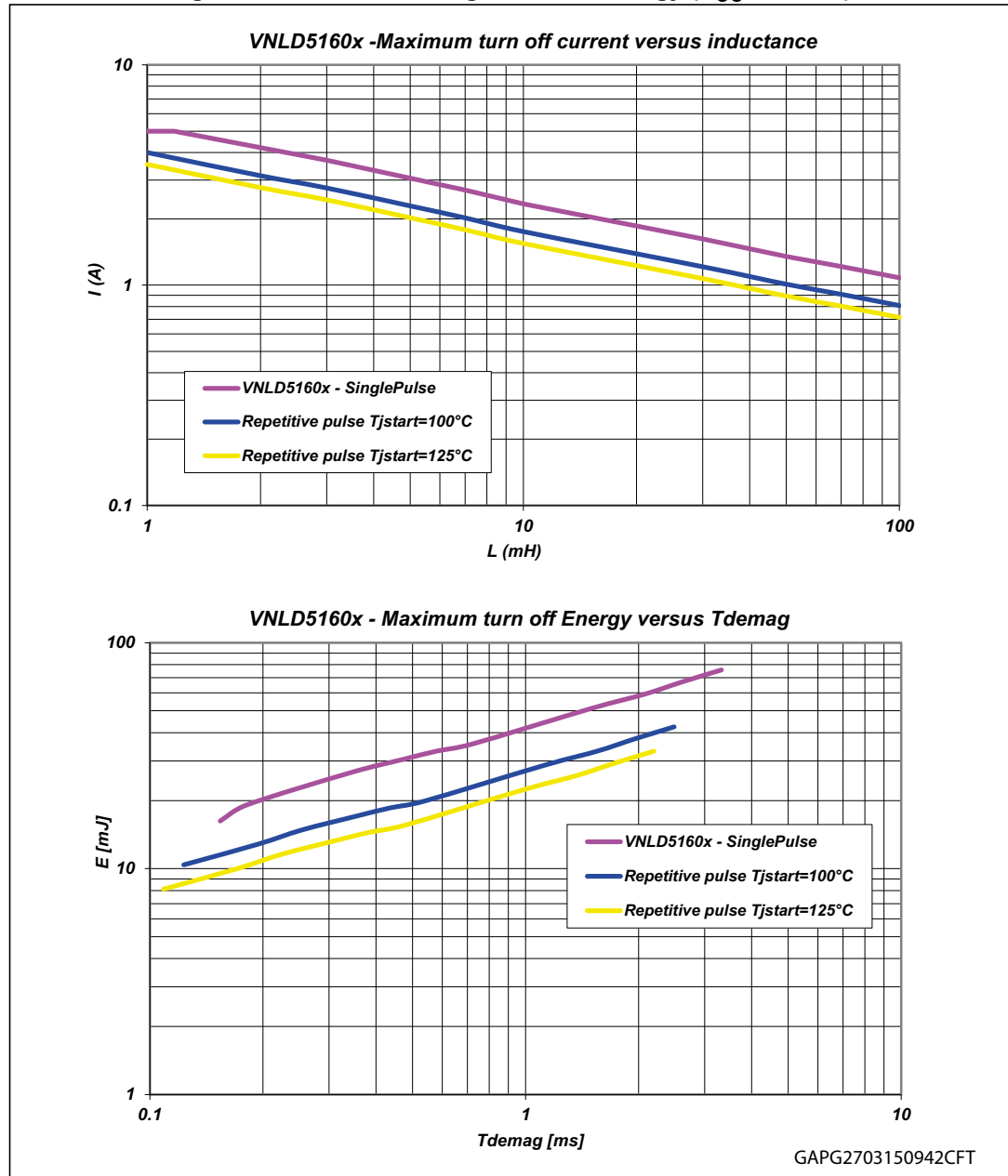
Let:

- $I_{latchup} \geq 20 \text{ mA}$
- $V_{OH\mu C} \geq 4.5 \text{ V}$
- $35 \Omega \leq R_{prot} \leq 100 \text{ K}\Omega$

Then, the recommended value is  $R_{prot} = 10 \text{ K}\Omega$

Figure 6 shows the turn-off current drawn during the demagnetization.

Figure 6. Maximum demagnetization energy ( $V_{CC} = 13.5 \text{ V}$ )

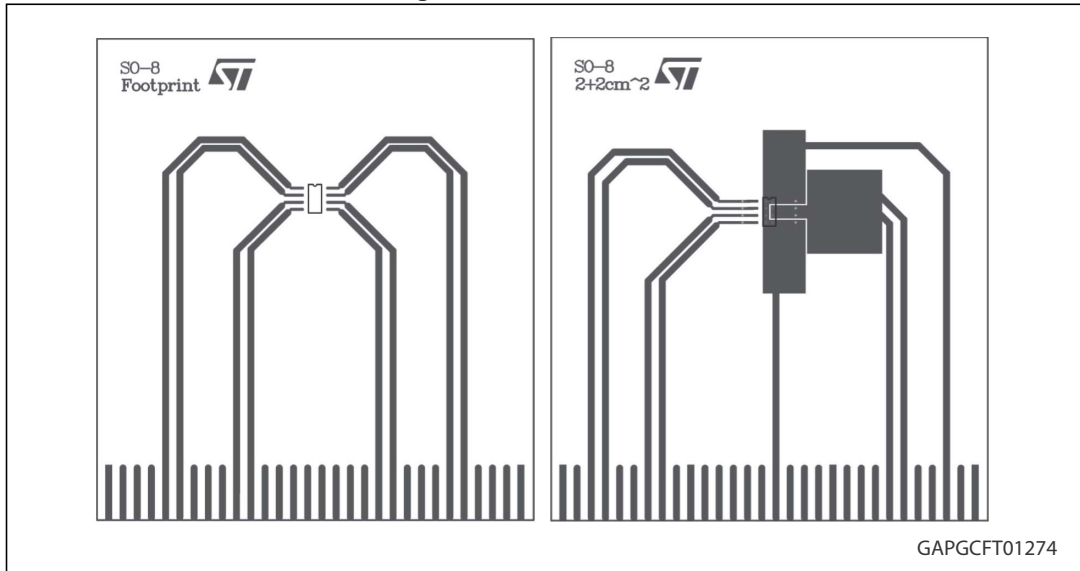


1. Values are generated with  $R_{\text{prot}} = 0\Omega$ .  
In case of repetitive pulses,  $T_{jstart}$  (at the beginning of each demagnetization) of every pulse must not exceed the temperature specified above for curves A and B

## 4 Package and PC board thermal data

### 4.1 SO-8 thermal data

Figure 7. SO-8 PC board



1. Layout condition of  $R_{th}$  and  $Z_{th}$  measurements (Board finish thickness 1.6 mm +/- 10%; Board double layer; Board dimension 78 mm x 86 mm; Board Material FR4; Cu thickness 0.070 mm (front and back side); Thermal vias separation 1.2 mm; Thermal via diameter 0.3 mm +/- 0.08 mm; Cu thickness on vias 0.025 mm).

Figure 8.  $R_{thj-amb}$  vs PCB copper area in open box free air condition

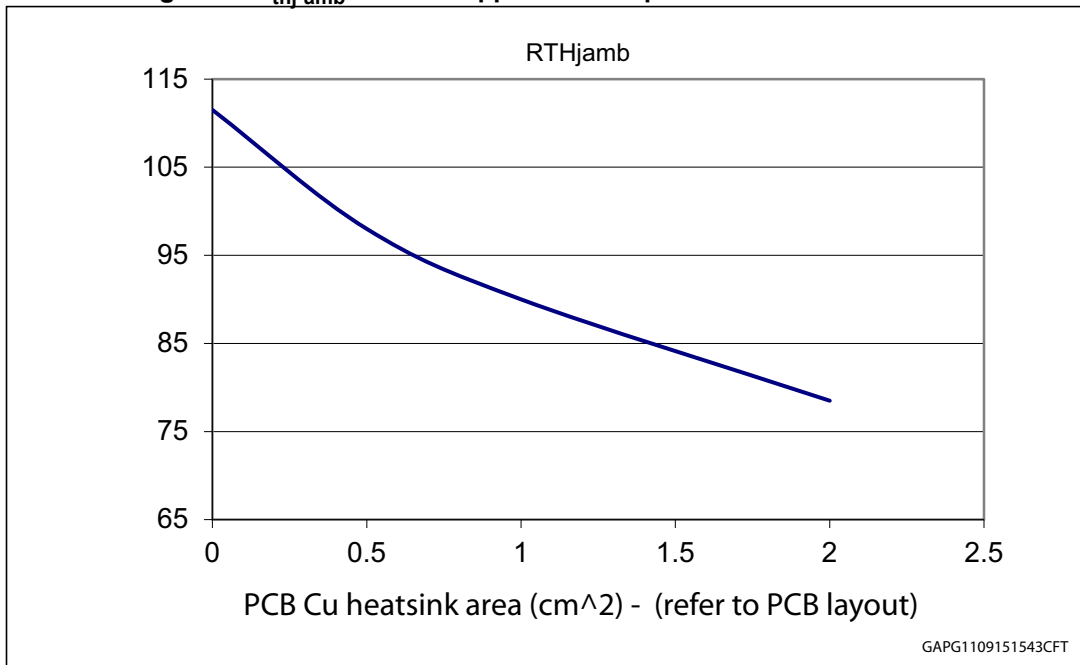
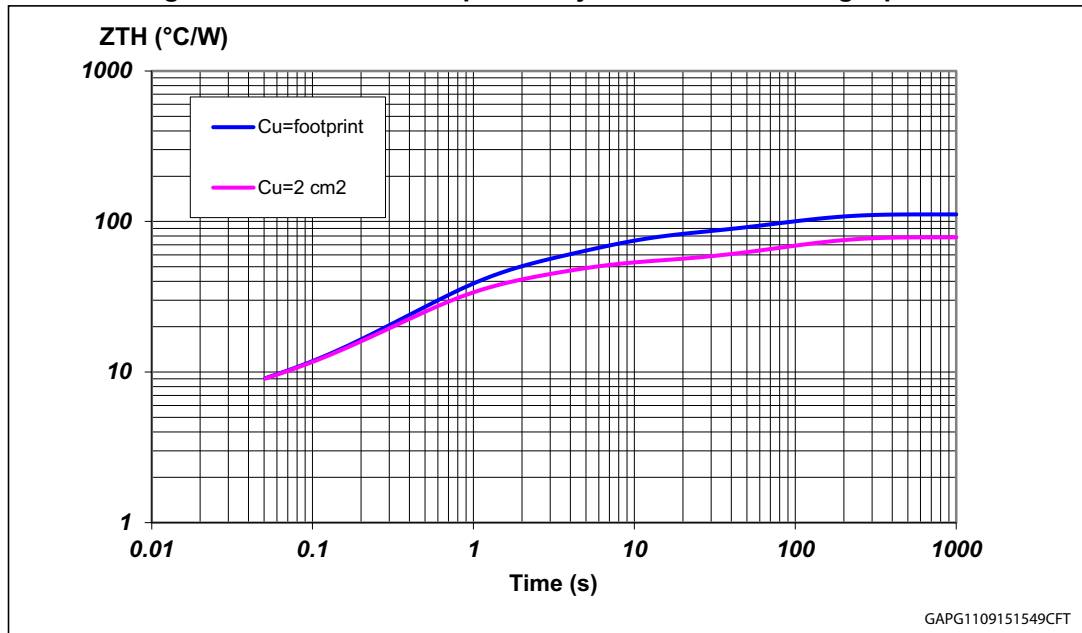


Figure 9. SO-8 thermal impedance junction ambient single pulse

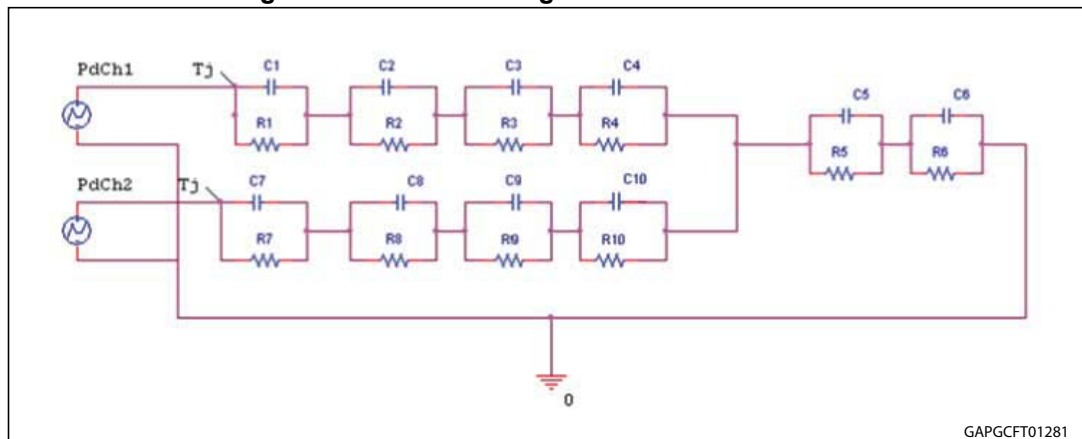


Equation 2: pulse calculation formula

$$Z_{TH\delta} = R_{TH} \cdot \delta + Z_{THtp}(1 - \delta)$$

where  $\delta = t_p/T$

Figure 10. Thermal fitting model of a LSD in SO-8



Note: The fitting model is a simplified thermal tool and is valid for transient evolutions where the embedded protections (power limitation or thermal cycling during thermal shutdown) are not triggered.

Table 13. Thermal parameters

Area/island (cm <sup>2</sup> )	Footprint	2
R1 = R7 (°C/W)	1	1
R2 = R8 (°C/W)	2	2
R3 = R9 (°C/W)	3.5	3.5
R4 = R10 (°C/W)	34	25
R5 (°C/W)	36	20
R6 (°C/W)	35	27
C1 = C7 (W.s/°C)	0.00005	0.00005
C2 = C8 (W.s/°C)	0.002	0.002
C3 = C9 (W.s/°C)	0.005	0.005
C4 = C10 (W.s/°C)	0.02	0.02
C5 (W.s/°C)	0.15	0.15
C6 (W.s/°C)	2.5	3.5

## 5 Package and packing information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK<sup>®</sup> is an ST trademark.

### 5.1 SO-8 package information

Figure 11. SO-8 package outline

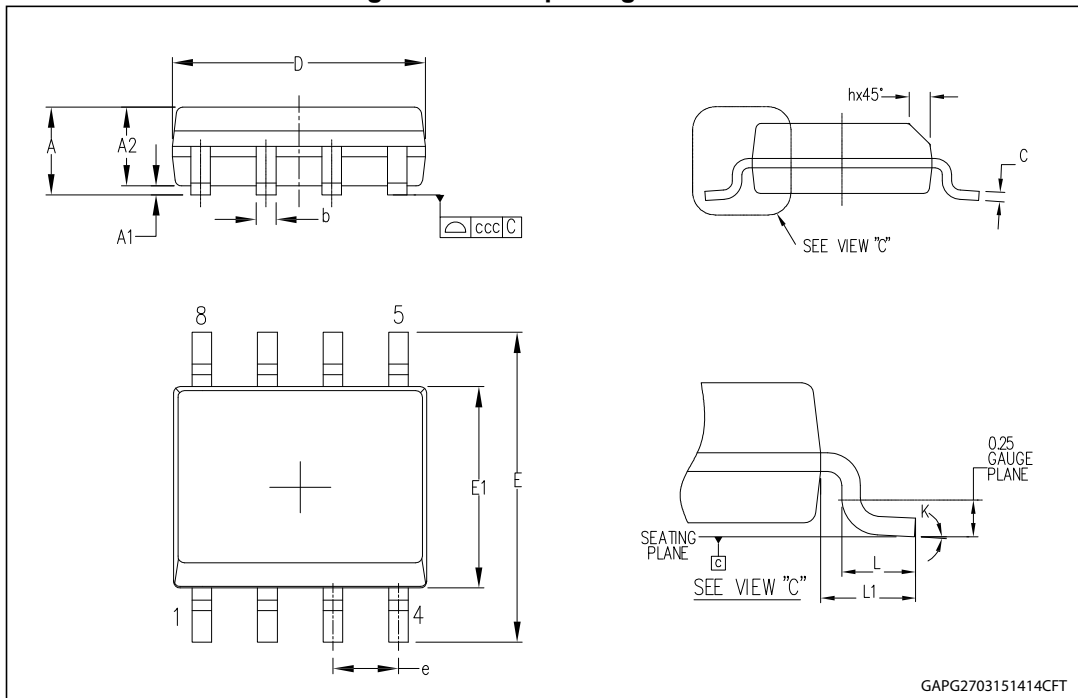




Table 14. SO-8 mechanical data

Symbol	Millimeters		
	Min.	Typ.	Max.
A			1.75
A1	0.10		0.25
A2	1.25		
b	0.28		0.48
c	0.17		0.23
D <sup>(1)</sup>	4.80	4.90	5.00
E	5.80	6.00	6.20
E1 <sup>(2)</sup>	3.80	3.90	4.00
e		1.27	
h	0.25		0.50
L	0.40		1.27
L1		1.04	
k	0°		8°
ccc			0.10

1. Dimensions D does not include mold flash, protrusions or gate burrs. Mold flash, protrusions or gate burrs shall not exceed 0.15 mm in total (both side).
2. Dimension "E1" does not include interlead flash or protrusions. Interlead flash or protrusions shall not exceed 0.25 mm per side.

## 5.2 SO-8 packing information

Figure 12. SO-8 tube shipment (no suffix)

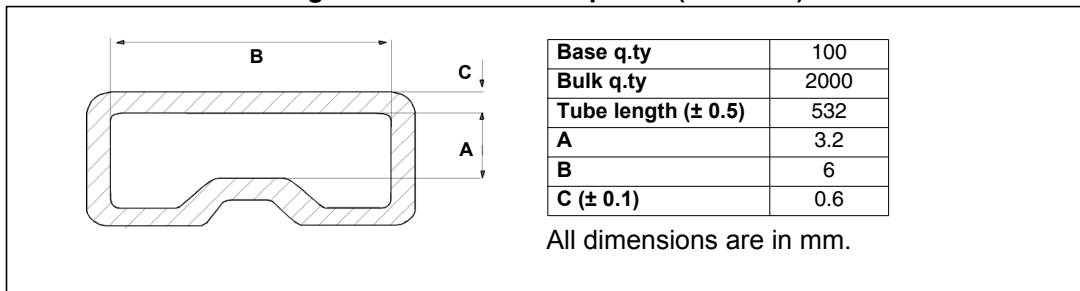
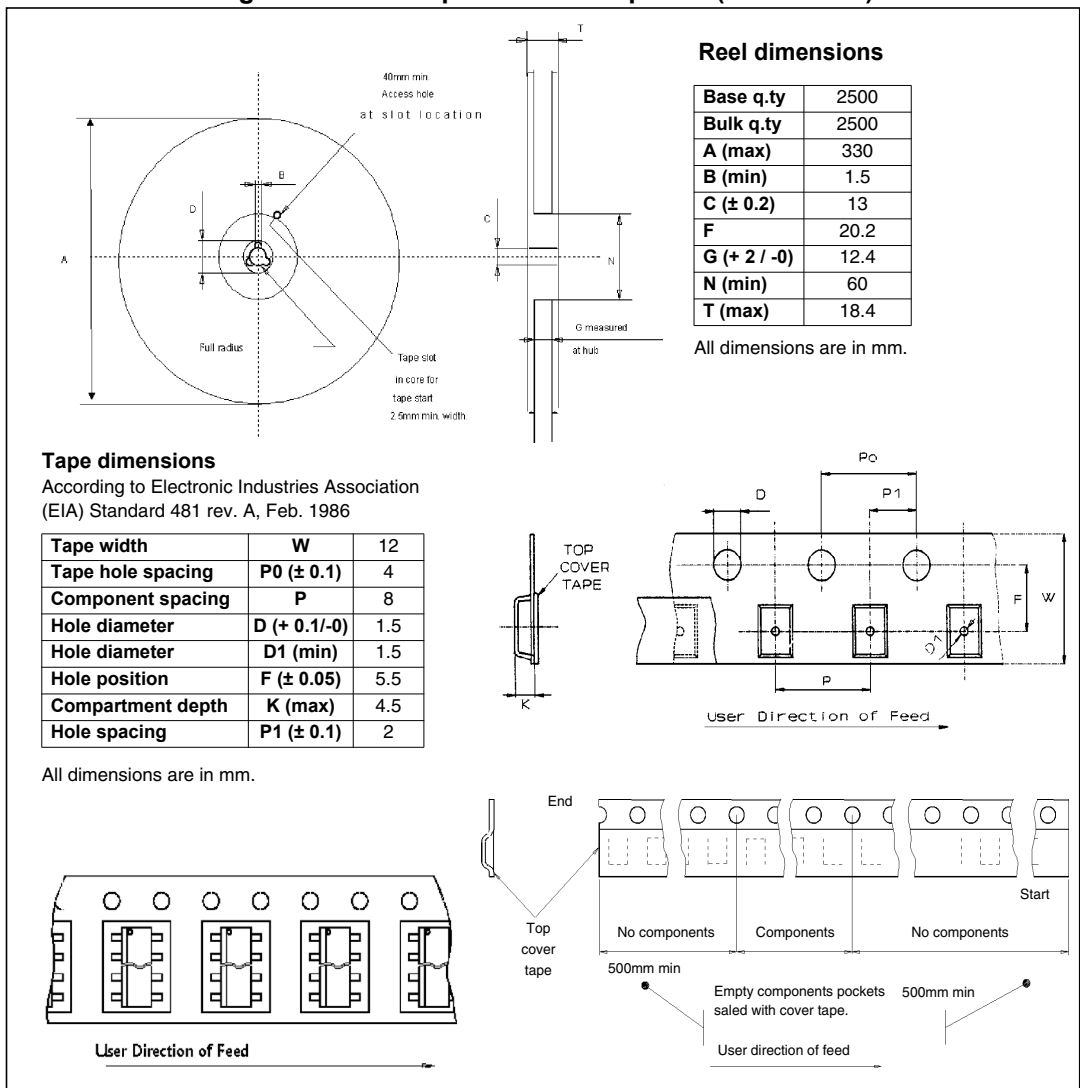


Figure 13. SO-8 tape and reel shipment (suffix "TR")



## 6 Revision history

**Table 15. Document revision history**

Date	Revision	Changes
02-Apr-2015	1	Initial release.
14-Sep-2015	2	Updated <i>Table 5: Thermal data</i> Updated <i>Chapter 4: Package and PC board thermal data</i>
26-Oct-2017	3	Added in cover page “automotive” word in the title and the icon of the car. Updated <i>Features on page 1</i> .

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